

FORM PTO-1449
INFORMATION DISCLOSURE CITATIONS
IN AN APPLICATION

Atty Docket: 58082.US
Applicant: Gary R. Janik
Filing Date: 2003.04.16

Serial #:

Group:

710/414905
U.S. Pat. Off.
7/10/03

U.S. PATENT DOCUMENTS

| Examiner Initial | Cite # | Document Number | Date | Name | Class | Sub-Class | Filing Date |
|------------------|--------|-----------------|------------|---------------|-------|-----------|-------------|
| CCR | 1 | 6,507,634 | 2003.01.14 | Koppel et al. | 378 | 54 | 2002.02.04 |
| CCR | 2 | 6,453,006 | 2002.09.17 | Koppel et al. | 378 | 86 | 2000.03.16 |
| CCR | 3 | 5,619,548 | 1997.04.08 | Koppel | 378 | 70 | 1995.08.11 |
| CCR | 4 | 2,853,617 | 1958.09.23 | Benneman | 250 | 51 | 1955.01.27 |

FOREIGN PATENT DOCUMENTS

| Examiner Initial | Cite # | Document Number | Date | Country | Class | Sub-Class | Translation |
|------------------|--------|-----------------|------|---------|-------|-----------|-------------|
| | | | | | | | |

OTHER NON-PATENT DOCUMENTS

| Examiner Initial | Cite # | Author, title, date, pertinent pages, etc. |
|------------------|--------|--|
| CCR | 5 | Naudon et al., New Apparatus for Grazing X-ray Reflectometry in the Angle-Resolved Dispersive Mode, J. Appl. Cryst., Vol. 22, pp. 460-464, 1989. |

Chenot

11/03

| Examiner | Date Considered: |
|--|------------------|
| EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant. | |

58082.1449.doc